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Form PTO 1449	U.S. DEPARTMENT OF COMMERCE			ATTY DOCKET NO.		SERIAL NO.	
(Modified)		PATENT AND TRADE	MARK OFFICE	218877US2PCT		New US PCT application based on PCT/JP00/07000	
	DE E E E			APPLICANT			
LIST OF	REFE	RENCES CITED BY APPL	ICANT	Masatoshi KATAYAMA			
				FILING DATE		GROUP	
Herewith							
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB FILING DATE CLASS IF APPROPRIATE	
	AA						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO	
L	AO	9-64820	03/07/97	JP			No
di 1	AP	11-305044	11/05/99	JP .			No ·
Vi~ .	AQ	6-250017	09/09/94	JP			No
Ju.	AR	63-132205	06/04/88	JP	~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~		No
du.	AS	5-112635	05/07/93	JP			No
Lu '	AT	5-142600	06/11/93	JP			No
~ ·	AU	5-063659	03/12/93	JP			No
38	AV	4-037225	02/07/92	JP			No
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
Hitachi Hyoron, vol. 77, no. 9, pages 15-18							
	AW	Hitachi Hyoronsha, 09/01/95					
	AX						
	AY						
	AZ	,			Addi	tional Refe	erences sheet(s) attached
Examiner					Date Considered 8/1/05		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							